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BUK7Y15-100E

N-channel 100 V, 15 mΩ standard level MOSFET in LPAK56

8 May 2013

Product data sheet

1. General description

Standard level N-channel MOSFET in an LPAK56 (Power SO8) package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

2. Features and benefits

- Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True standard level gate with $V_{GS(th)}$ rating of greater than 1 V at 175 °C

3. Applications

- 12 V, 24 V and 48 V Automotive systems
- Motors, lamps and solenoid control
- Transmission control
- Ultra high performance power switching

4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--------------------------------|----------------------------------|--|-----|------|-----|------|
| V_{DS} | drain-source voltage | $T_j \geq 25\text{ °C}$; $T_j \leq 175\text{ °C}$ | - | - | 100 | V |
| I_D | drain current | $V_{GS} = 10\text{ V}$; $T_{mb} = 25\text{ °C}$; Fig. 1 | - | - | 68 | A |
| P_{tot} | total power dissipation | $T_{mb} = 25\text{ °C}$; Fig. 2 | - | - | 195 | W |
| Static characteristics | | | | | | |
| $R_{DS(on)}$ | drain-source on-state resistance | $V_{GS} = 10\text{ V}$; $I_D = 20\text{ A}$; $T_j = 25\text{ °C}$; Fig. 11 | - | 10 | 15 | mΩ |
| Dynamic characteristics | | | | | | |
| Q_{GD} | gate-drain charge | $V_{GS} = 10\text{ V}$; $I_D = 20\text{ A}$; $V_{DS} = 80\text{ V}$; $T_j = 25\text{ °C}$; Fig. 13 ; Fig. 14 | - | 17.7 | - | nC |



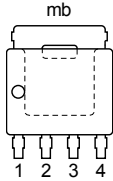
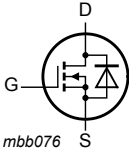
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5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-----------------------------------|--|---|
| 1 | S | source |  <p>LPAK56; Power-SO8 (SOT669)</p> |  <p>mbb076</p> |
| 2 | S | source | | |
| 3 | S | source | | |
| 4 | G | gate | | |
| mb | D | mounting base; connected to drain | | |

6. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|--------------|-------------------|---|---------|
| | Name | Description | Version |
| BUK7Y15-100E | LPAK56; Power-SO8 | Plastic single-ended surface-mounted package (LPAK56; Power-SO8); 4 leads | SOT669 |

7. Marking

Table 4. Marking codes

| Type number | Marking code |
|--------------|--------------|
| BUK7Y15-100E | 71510E |

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------|-------------------------|---|-----|-----|------|
| V_{DS} | drain-source voltage | $T_j \geq 25\text{ °C}$; $T_j \leq 175\text{ °C}$ | - | 100 | V |
| V_{DGR} | drain-gate voltage | $R_{GS} = 20\text{ k}\Omega$ | - | 100 | V |
| V_{GS} | gate-source voltage | $T_j \leq 175\text{ °C}$; DC | -20 | 20 | V |
| I_D | drain current | $T_{mb} = 25\text{ °C}$; $V_{GS} = 10\text{ V}$; Fig. 1 | - | 68 | A |
| | | $T_{mb} = 100\text{ °C}$; $V_{GS} = 10\text{ V}$; Fig. 1 | - | 48 | A |
| I_{DM} | peak drain current | $T_{mb} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$; Fig. 4 | - | 274 | A |
| P_{tot} | total power dissipation | $T_{mb} = 25\text{ °C}$; Fig. 2 | - | 195 | W |
| T_{stg} | storage temperature | | -55 | 175 | °C |

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| Symbol | Parameter | Conditions | | Min | Max | Unit |
|-----------------------------|--|---|------------------------|-----|-----|------|
| T_j | junction temperature | | | -55 | 175 | °C |
| Source-drain diode | | | | | | |
| I_S | source current | $T_{mb} = 25\text{ °C}$ | | - | 68 | A |
| I_{SM} | peak source current | pulsed; $t_p \leq 10\text{ }\mu\text{s}$; $T_{mb} = 25\text{ °C}$ | | - | 274 | A |
| Avalanche ruggedness | | | | | | |
| $E_{DS(AL)S}$ | non-repetitive drain-source avalanche energy | $I_D = 68\text{ A}$; $V_{sup} \leq 100\text{ V}$; $R_{GS} = 50\text{ }\Omega$; $V_{GS} = 10\text{ V}$; $T_{j(\text{init})} = 25\text{ °C}$; unclamped; Fig. 3 | [1][2] | - | 111 | mJ |

[1] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

[2] Refer to application note AN10273 for further information.

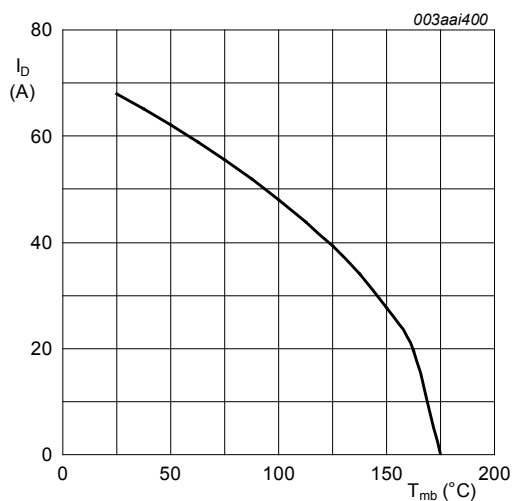


Fig. 1. Continuous drain current as a function of mounting base temperature

$$V_{GS} \geq 10V$$

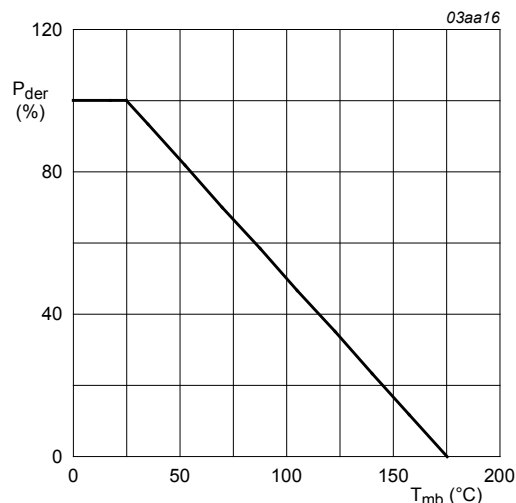


Fig. 2. Normalized total power dissipation as a function of mounting base temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}\text{C})}} \times 100\%$$

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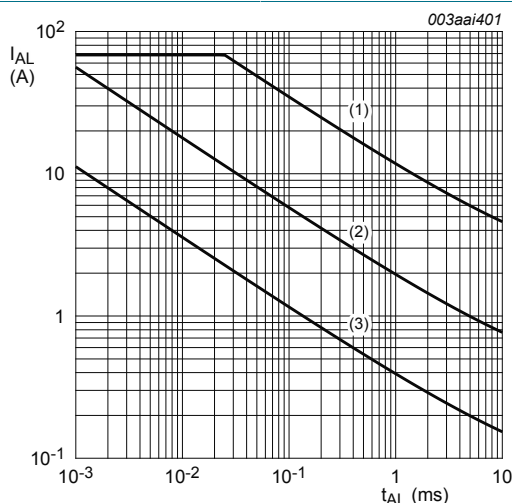


Fig. 3. Avalanche rating; avalanche current as a function of avalanche time

(1) $T_{j (init)} = 25^{\circ}\text{C}$; (2) $T_{j (init)} = 150^{\circ}\text{C}$; (3) Repetitive Avalanche

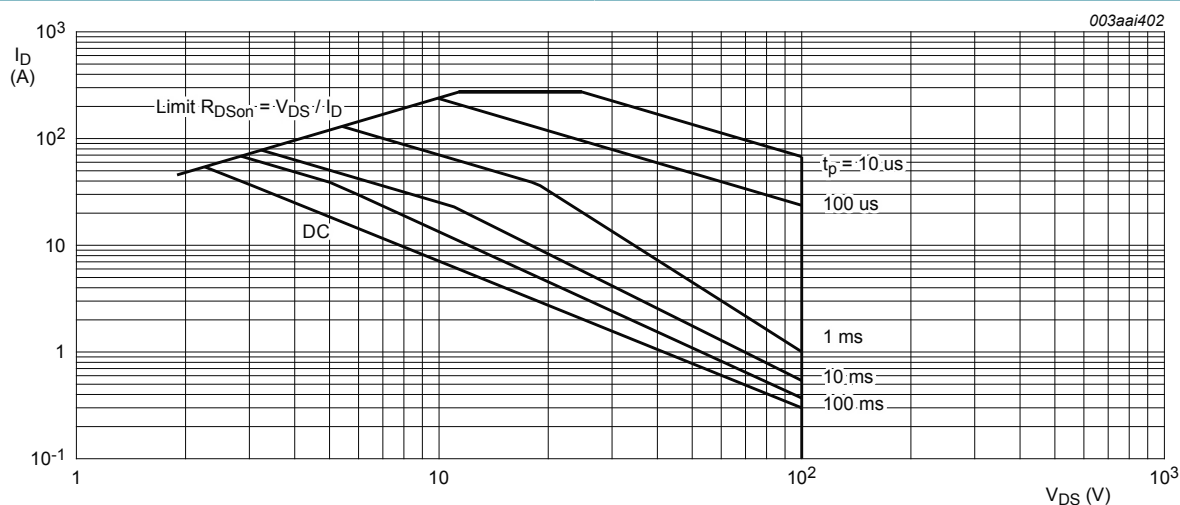


Fig. 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

$T_{mb} = 25^{\circ}\text{C}$; I_{DM} is a single pulse

9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------------|---|------------|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | Fig. 5 | - | - | 0.77 | K/W |

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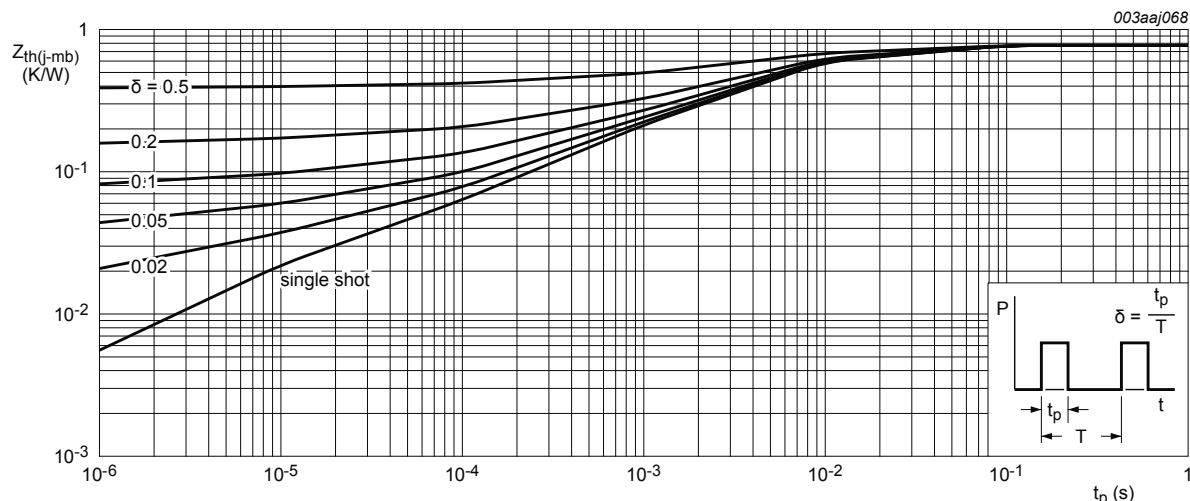


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Characteristics

Table 7. Characteristics

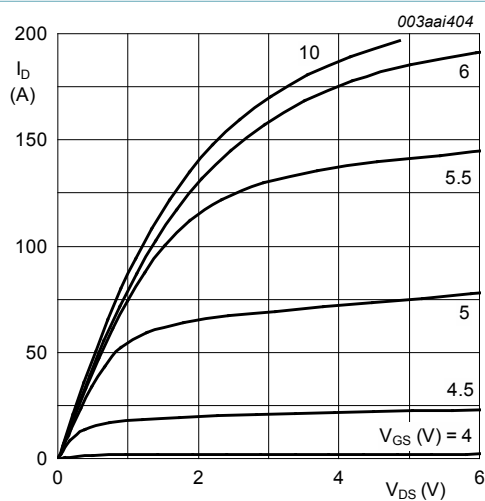
| Symbol | Parameter | Conditions | | Min | Typ | Max | Unit |
|-------------------------|-------------------------------------|---|--|-----|------|------|------------|
| Static characteristics | | | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $I_D = 250\ \mu A; V_{GS} = 0\ V; T_j = 25\ ^\circ C$ | | 100 | - | - | V |
| | | $I_D = 250\ \mu A; V_{GS} = 0\ V; T_j = -55\ ^\circ C$ | | 90 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D = 1\ mA; V_{DS} = V_{GS}; T_j = 25\ ^\circ C;$ Fig. 9 ; Fig. 10 | | 2.4 | 3 | 4 | V |
| | | $I_D = 1\ mA; V_{DS} = V_{GS}; T_j = -55\ ^\circ C;$ Fig. 9 | | - | - | 4.5 | V |
| | | $I_D = 1\ mA; V_{DS} = V_{GS}; T_j = 175\ ^\circ C;$ Fig. 9 | | 1 | - | - | V |
| I_{DSS} | drain leakage current | $V_{DS} = 100\ V; V_{GS} = 0\ V; T_j = 25\ ^\circ C$ | | - | 0.13 | 10 | μA |
| | | $V_{DS} = 100\ V; V_{GS} = 0\ V; T_j = 175\ ^\circ C$ | | - | - | 500 | μA |
| I_{GSS} | gate leakage current | $V_{GS} = 20\ V; V_{DS} = 0\ V; T_j = 25\ ^\circ C$ | | - | 2 | 100 | nA |
| | | $V_{GS} = -20\ V; V_{DS} = 0\ V; T_j = 25\ ^\circ C$ | | - | 2 | 100 | nA |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 10\ V; I_D = 20\ A; T_j = 25\ ^\circ C;$ Fig. 11 | | - | 10 | 15 | m Ω |
| | | $V_{GS} = 10\ V; I_D = 20\ A; T_j = 175\ ^\circ C;$ Fig. 11 ; Fig. 12 | | - | - | 41.5 | m Ω |
| Dynamic characteristics | | | | | | | |
| $Q_{G(tot)}$ | total gate charge | $I_D = 20\ A; V_{DS} = 80\ V; V_{GS} = 10\ V;$ $T_j = 25\ ^\circ C;$ Fig. 13 ; Fig. 14 | | - | 54.5 | - | nC |
| Q_{GS} | gate-source charge | | | - | 12.3 | - | nC |
| Q_{GD} | gate-drain charge | | | - | 17.7 | - | nC |

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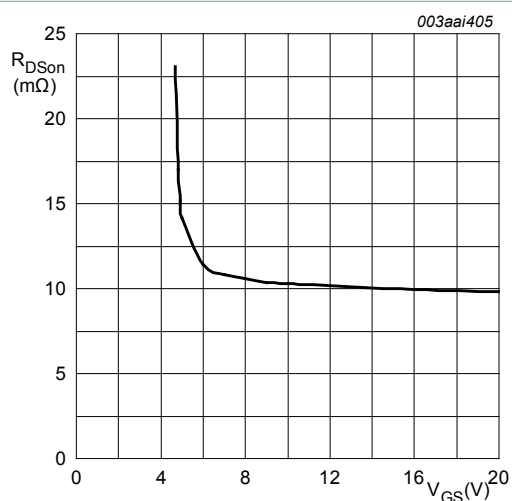
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| Symbol | Parameter | Conditions | | Min | Typ | Max | Unit |
|---------------------|------------------------------|--|--|-----|------|------|------|
| C _{iss} | input capacitance | V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz; T _j = 25 °C; Fig. 15 | | - | 2968 | 3958 | pF |
| C _{oss} | output capacitance | | | - | 283 | 340 | pF |
| C _{rss} | reverse transfer capacitance | | | - | 195 | 267 | pF |
| t _{d(on)} | turn-on delay time | V _{DS} = 80 V; R _L = 4 Ω; V _{GS} = 10 V; R _{G(ext)} = 5 Ω; T _j = 25 °C | | - | 11 | - | ns |
| t _r | rise time | | | - | 21 | - | ns |
| t _{d(off)} | turn-off delay time | | | - | 43 | - | ns |
| t _f | fall time | | | - | 24 | - | ns |
| Source-drain diode | | | | | | | |
| V _{SD} | source-drain voltage | I _S = 20 A; V _{GS} = 0 V; T _j = 25 °C; Fig. 16 | | - | 0.82 | 1.2 | V |
| t _{rr} | reverse recovery time | I _S = 20 A; dI _S /dt = -100 A/μs; V _{GS} = 0 V; V _{DS} = 25 V; T _j = 25 °C | | - | 42 | - | ns |
| Q _r | recovered charge | | | - | 82 | - | nC |



$T_j = 25\text{ }^{\circ}\text{C}; t_p = 300\text{ }\mu\text{s}$

Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values



$T_j = 25\text{ }^{\circ}\text{C}; I_D = 20\text{ A}$

Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

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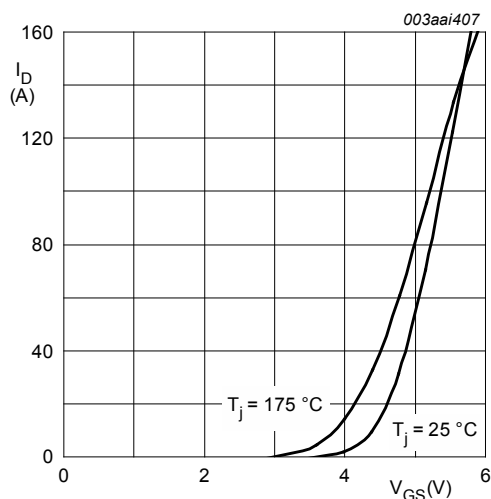


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values

$$V_{DS} = 10V$$

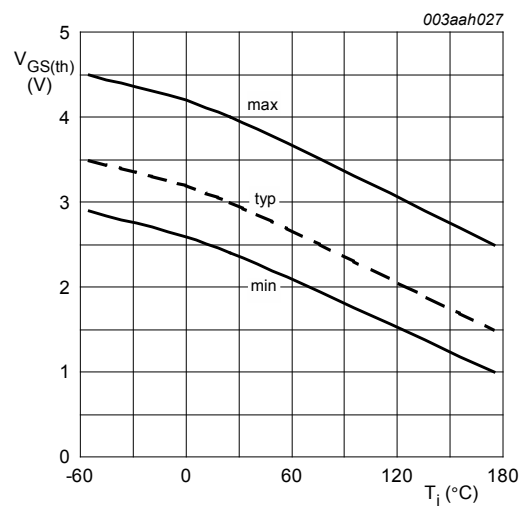


Fig. 9. Gate-source threshold voltage as a function of junction temperature

$$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$$

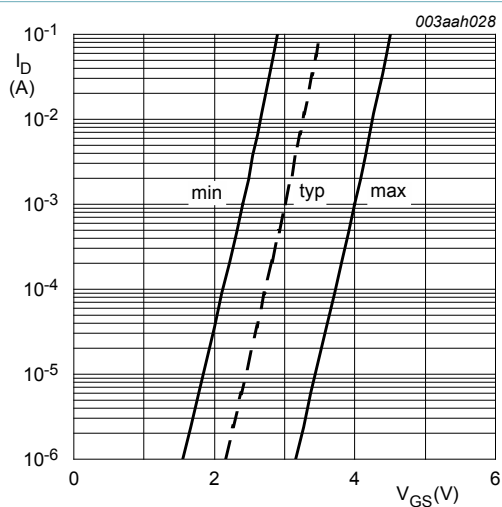


Fig. 10. Sub-threshold drain current as a function of gate-source voltage

$$T_j = 25^\circ\text{C}; V_{DS} = 5V$$

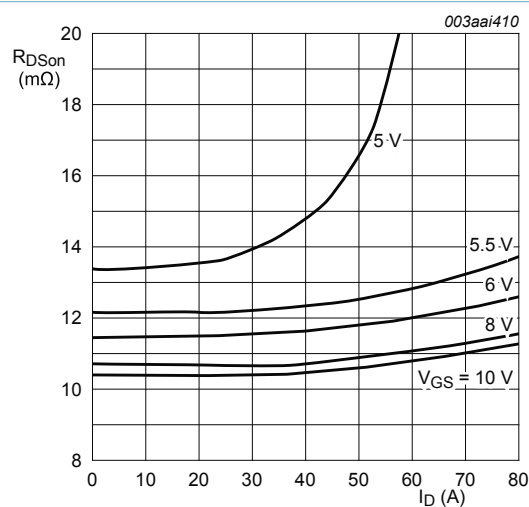


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values

$$T_j = 25^\circ\text{C}; t_p = 300 \mu\text{s}$$

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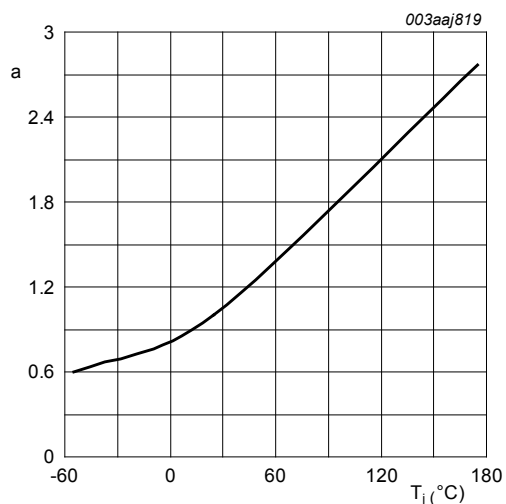


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature

$$a = \frac{R_{DS(on)}}{R_{DS(on)}(25^{\circ}\text{C})}$$

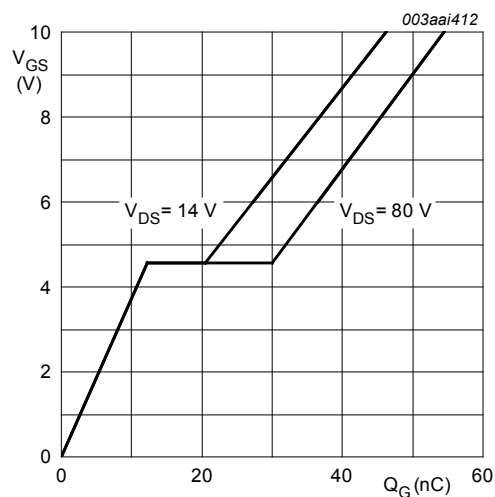


Fig. 13. Gate-source voltage as a function of gate charge; typical values

$$T_j = 25^{\circ}\text{C}; I_D = 20\text{A}$$

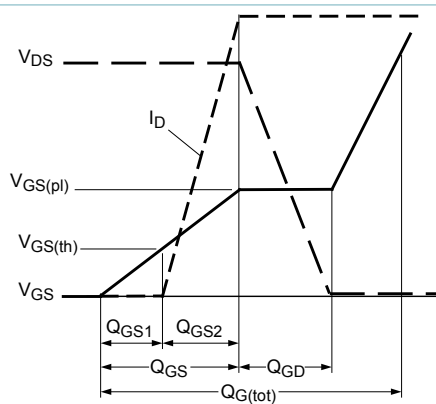


Fig. 14. Gate charge waveform definitions

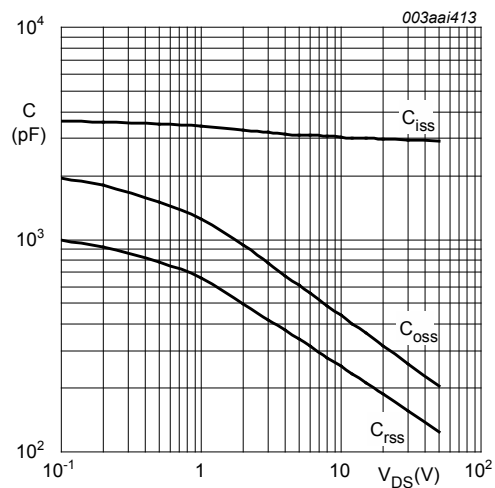


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

$$V_{GS} = 0\text{V}; f = 1\text{MHz}$$

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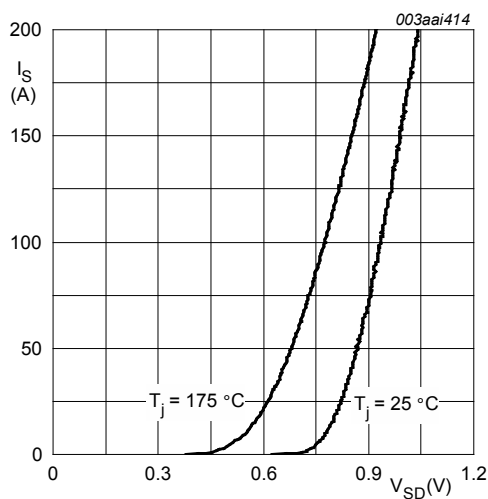


Fig. 16. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

$$V_{GS} = 0V$$

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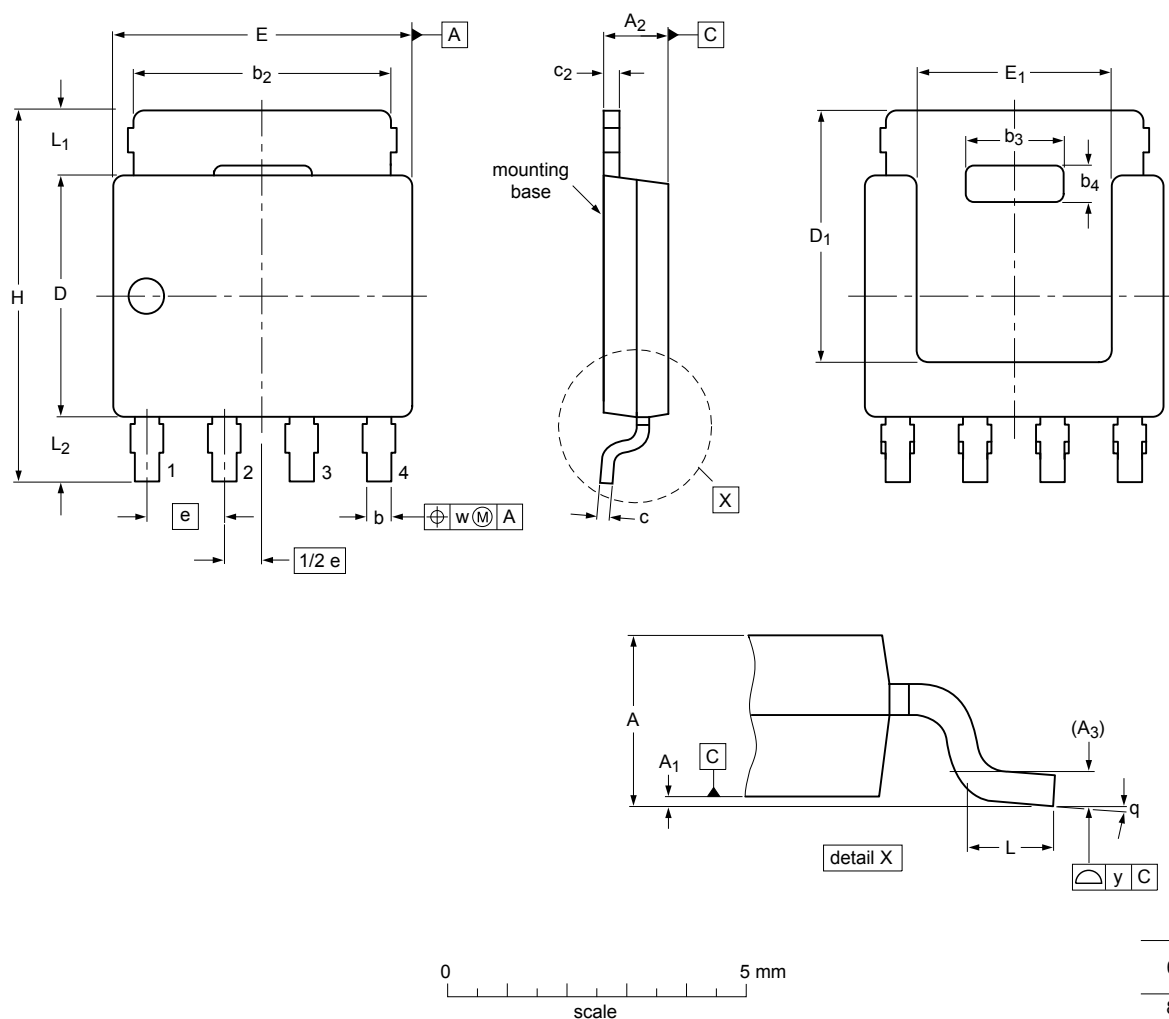
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11. Package outline

Plastic single-ended surface-mounted package (LPAK56; Power-SO8); 4 leads

SOT669



Dimensions (mm are the original dimensions)

| Unit ⁽¹⁾ | A | A ₁ | A ₂ | A ₃ | b | b ₂ | b ₃ | b ₄ | c | c ₂ | D ⁽¹⁾ | D ₁ ⁽¹⁾ | E ⁽¹⁾ | E ₁ ⁽¹⁾ | e | H | L | L ₁ | L ₂ | w | y |
|---------------------|------|----------------|----------------|----------------|------|----------------|----------------|----------------|------|----------------|------------------|-------------------------------|------------------|-------------------------------|------|-----|------|----------------|----------------|------|-----|
| max | 1.20 | 0.15 | 1.10 | | 0.50 | 4.41 | 2.2 | 0.9 | 0.25 | 0.30 | 4.10 | 4.20 | 5.0 | 3.3 | | 6.2 | 0.85 | 1.3 | 1.3 | | |
| nom | | | | 0.25 | | | | | | | | | | | 1.27 | | | | | 0.25 | 0.1 |
| min | 1.01 | 0.00 | 0.95 | | 0.35 | 3.62 | 2.0 | 0.7 | 0.19 | 0.24 | 3.80 | | 4.8 | 3.1 | | 5.8 | 0.40 | 0.8 | 0.8 | | |

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

sot669_po

| Outline version | References | | | | European projection | Issue date |
|-----------------|------------|--------|-------|--|---------------------|------------------------|
| | IEC | JEDEC | JEITA | | | |
| SOT669 | | MO-235 | | | | -11-03-25- 13-02-27 |

Fig. 17. Package outline LPAK56; Power-SO8 (SOT669)

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12. Legal information

12.1 Data sheet status

| Document status [1][2] | Product status [3] | Definition |
|--------------------------------|--------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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- [2] The term 'short data sheet' is explained in section "Definitions".
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